

Notice of References Cited	Application/Control No. 10/809,776	Applicant(s)/Patent Under Reexamination HUREWITZ ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,295,242 A	03-1994	Mashruwala et al.	715/853
*	B	US-5,493,658 A	02-1996	Chiang et al.	715/709
*	C	US-5,539,872 A	07-1996	Mintz et al.	715/810
*	D	US-5,801,702 A	09-1998	Dolan et al.	715/854
*	E	US-5,920,315 A	07-1999	Santos-Gomez, Lucinio	715/792
*	F	US-6,177,936 B1	01-2001	Cragun, Brian John	715/760
*	G	US-2003/0004929 A1	01-2003	Julian et al.	707/2
*	H	US-2003/0117443 A1	06-2003	Langner et al.	345/810
*	I	US-2003/0160829 A1	08-2003	Miksovsky et al.	345/804
*	J	US-2004/0068431 A1	04-2004	Smith et al.	705/010
*	K	US-2005/0210406 A1	09-2005	Biwer et al.	715/804
*	L	US-7,017,121 B1	03-2006	Gikas et al.	715/804
*	M	US-7,188,317 B1	03-2007	Hazel, Thomas G.	715/804


FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,408,655 A	04-1995	Oren et al.	715/501.1
*	B	US-5,546,529 A	08-1996	Bowers et al.	715/848
*	C	US-5,594,899 A	01-1997	Knudsen et al.	707/2
*	D	US-5,708,787 A	01-1998	Nakano et al.	715/841
*	E	US-5,786,818 A	07-1998	Brewer et al.	715/822
*	F	US-5,940,820 A	08-1999	Kagiwada, Keiji	707/3
*	G	US-6,334,131 B1	12-2001	Chakrabarti et al.	707/10
*	H	US-6,338,067 B1	01-2002	Baker et al.	707/100
*	I	US-6,363,353 B1	03-2002	Chen, Li-Wen	705/10
*	J	US-6,577,304 B1	06-2003	Yablonski et al.	345/419
*	K	US-6,711,589 B2	03-2004	Dietz, Timothy Alan	707/104.1
*	L	US-7,007,029 B1	02-2006	Chen, Li-Wen	707/100
*	M	US-7,149,698 B2	12-2006	Guheen et al.	705/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0046214 A1	03-2003	Menninger, Anthony Frank	705/37
*	B	US-2002/0099598 A1	07-2002	Eicher et al.	705/11
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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